Preparation of Nanostructured Fluorine Doped Tin Oxide (FTO) by Hydrothermal Method

Asyikin Sasha Mohd Hanif\textsuperscript{1,a}, Lau Weng Kuen\textsuperscript{1,b}, Fariza Mohamad\textsuperscript{1,c}, Wan Suhaizam Wan Zaki\textsuperscript{1,d}, and Mohd Khairul Ahmad\textsuperscript{1,e}

\textsuperscript{1}Microelectronic and Nanotechnology – Shamsuddin Research Centre (Mint-SRC), Universiti Tun Hussein Onn Malaysia, Parit Raja, 86400, Batu Pahat, Johor, Malaysia

\textsuperscript{a}asyikinsasha@gmail.com, \textsuperscript{b}ae100186@siswa.uthm.edu.my, \textsuperscript{c}farizamt@uthm.edu.my \textsuperscript{d}mizan@uthm.edu.my, \textsuperscript{e}akhairul@uthm.edu.my

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Abstract. This study demonstrates the fabrication of nanostructured FTO by hydrothermal method. It was directly synthesized on FTO glass substrate by using pentahydrate stannic chloride (SnCl\textsubscript{4}.5H\textsubscript{2}O) and ammonium fluoride (NH\textsubscript{4}F) as precursors. Different synthesis time was applied which were 5h, 10h and 24h. The characteristics of nanostructured FTO were investigated via field emission scanning electron microscopy (FESEM), two-point probe current-voltage test and ultraviolet visible spectrometer (UV-Vis). The FESEM images revealed the growth of nano-sized particles layer on the FTO substrate. The electrical properties studied have shown a degeneration of conductivity as the thickness of nanostructured layer increased. UV-Vis results showed the decrement of transmittance as the time duration increased. It was revealed through FESEM characterization that the nanostructured FTO can be improved by using dibutyltin diacetate (DBTA) as a precursor.

Introduction

Transparent conducting oxides (TCO) have been extensively studied over the past decades due to its wide band gap which improvised the high optical transmittance (up to 90\%) with low electrical resistivity (i.e. few times 10\textsuperscript{-4} Ω cm), low thermal emittance and high infrared reflectivity [1-2]. There are a number of diverse applications of transparent conducting oxides in thin film technology including liquid crystal displays, thick film sensors, transparent electrodes in solar cells, flat panel displays, organic light emitting diodes and heat mirrors [3]. It has been reported, tin oxide (SnO\textsubscript{2}) thin film is one of the elements in TCO family which is transparent in the visible region and have high infrared reflectivity. Across the groups III, V, VI and VII elements of the periodic table, SnO\textsubscript{2} thin film can be doped with dopants such as tin doped indium oxide, In\textsubscript{2}O\textsubscript{3}:Sn (ITO), fluorine doped tin oxide, SnO\textsubscript{2}:F (FTO), antimony doped tin oxide, SnO\textsubscript{2}:Sb (ATO), aluminum doped zinc oxide, ZnO:Al (AZO) and gallium doped zinc oxide, ZnO:Ga (GZO). Among the elements mentioned, FTO thin film is the most frequently used dopant where it can be exhibited stably both thermally and chemically with high optical transparency in visible range and high electrical conductivity [4-5]. FTO thin film is a versatile n-type group VII semiconductor with its excellent properties for applications in solar cell window layers [6], gas sensor devices [7], substrates for electrodeposition [8], and transparent contact in optoelectronic devices and etc.

In this context, size control of the nano-scale is essential where the nanostructured FTO requires special attention relative to structural, optical and electrical properties. For instance, when a nanorod array grew on the seed layer, the nanorod is directly related to the nanoparticle size of the seed layer [9]. Various methods to prepare FTO has been reported which include sol-gel and spray pyrolysis deposition (SPD) [10], dc and rf sputtering [11], pulsed laser deposition [12], and chemical vapour deposition [13]. The properties of nanostructured FTO are relatively affected by the hydrothermal method as well as the experimental parameters. From previous studies, it was determined that the solution-based method offers low cost production, simple and high growth rate of seed layer on the nanostructured FTO compared to the amorphous method. For instance, the
The hydrothermal process of growing ZnO nanostructures has gained immense popularity due to its simplicity and tolerable growth conditions [14]. Liu and Aydil [15] have found a simple hydrothermal method for growing oriented single crystalline rutile TiO$_2$ nanorods on FTO substrates. When comparing to other techniques, hydrothermal method is a good candidate for the fabrication of nanostructured FTO thin film. Throughout the decades, various FTO nanostructures had been reported such as nanorods, nanobows, nanobelts and nanocages which exhibited different properties.

With these information, we made an attempt to prepare nanostructured FTO film for higher conductivity, higher optical transparency and low resistivity via hydrothermal method. This study focuses on the behavior of nanostructured FTO thin film in terms of structural, morphological and optical properties.

**Experimental**

The nanostructured FTO thin film was fabricated by hydrothermal method from the solution with the mixture of precursors pentahydrated stannic chloride (SnCl$_4$·5H$_2$O), ammonium fluoride (NH$_4$F) and 2-propanol. SnCl$_4$·5H$_2$O and NH$_4$F were dissolved separately in 30 ml of distilled water and both dissolved solution were stirred for 20 minutes. Then, they were mixed together and 30 ml of 2-propanol was added. The solution was stirred for another 20 minutes.

Prior to the solution preparation, FTO glass substrate with dimension 2.5cm x 1.0cm was cleaned using ultrasonicator in a solution containing 10 ml of acetone ((CH$_3$)$_2$CO), 10 ml of distilled water and 10 ml of propanol. The cleaning process was done at temperature 28 ºC for 10 minutes. The FTO glass substrate was then put onto sample stage which was earlier put in the Teflon-lined stainless autoclave tube filled with 90 ml of the prepared solution. The tube was put into the forced convection oven at temperature 150 ºC for 5h. This process was repeated for various time duration which were 10 and 24h. After the synthesis process, the glass substrate was taken out and rinsed extensively with deionized water and lastly, dried at 60 ºC in ambient air.

The samples were characterized for their morphological, electrical and optical properties via field-emission scanning electron microscopy (JEOL, Model: JSM-7600F), two-point probe I-V measurement (KEITHLY, Model: Series 2400 SourceMeter) and UV-Vis spectrometer (Shimadzu, Model: UV 1800), respectively.

**Results and Discussion**

**A. Morphological characterization**

Fig. 1, Fig. 2 and Fig. 3 depicted the FESEM images of nanostructured FTO thin film fabricated for 5h, 10h and 24h, respectively. It can be seen that the grain size and its distribution were greatly influenced by the synthesis time duration where the grain size increased when the time duration increased. At 5h, the layer of nanoparticles grew on top of FTO glass substrate surface with the smallest mean grain size of 310nm and average thickness of 1046nm. At 10h, the mean grain size increased 1.5 times to about 465nm and the thickness increased to 1133nm. While for 24h, the grain size was the largest among the three time duration which was 500nm and thickness of 3857nm.

Grain size and its distribution greatly affected the surface area and grain boundaries of the nanostructured FTO thin film. As lesser grain boundaries can cause larger conductivity and higher electron density, the lowest grain boundaries can be obtained by having the largest grain distribution. From FESEM images, 5h sample fulfilled this requirement. However, there were numbers of irregular grains, compact structures and different shapes at three different time duration. Another fabrication was done where 0.8M dibutyltin diacetate (DBTA) was dissolved in ethyl alcohol solution and 1.53M NH$_4$F dissolved in 90% water solution with 10% ethyl alcohol solution. FESEM images in Fig. 4 showed a more regular, small nanocrystal growth scattered on the FTO crystals. From morphological observations, hydrothermal using DBTA solution may exhibit higher potential for optimize performance of nanostructured FTO thin film.
Figure 1: FESEM images of 5h nanostructured FTO thin film grown on FTO substrate (left-right) top view at 10k magnification, top view at 30k magnification, cross-section view.

Figure 2: FESEM images of 10h nanostructured FTO thin film grown on FTO substrate (left-right) top view at 10k magnification, top view at 30k magnification, cross-section view.

Figure 3: FESEM images of 24h nanostructured FTO thin film grown on FTO substrate (left-right) top view at 10k magnification, top view at 30k magnification, cross-section view.

Figure 4: FESEM images of 5h nanostructured FTO by DBTA (left) top view at 10k magnification, (right) top view at 30k magnification.

B. Electrical properties

The variation of current versus voltage of nanostructured FTO thin film from -5V to 5V at different time duration of hydrothermal synthesis was shown in Fig. 5. There were shift of I-V gradient among the three different time duration where the 5h sample has the highest gradient, followed by 10h and then 24h.

Figure 5: The variation of I-V gradient with the three different time duration hydrothermal synthesis (a) 5 hours, (b) 10 hours, (c) 24 hours.
The resistance obtained from Fig. 5, the resistivity and the sheet resistance were summarized in Table 1. In the table, it was seen that the 5h sample had the lowest resistance of 70.713 Ω while 24h sample had the highest resistance of 183.639 Ω. This proved that the resistance is associated with the deposited layer thickness. While for resistivity and sheet resistance, the data were obtained from the equations shown below:

Resistivity, \( \rho \)
\[
\rho = \frac{R_s \times t}{10^3} \quad (1)
\]

Sheet resistance, \( R_s \)
\[
R_s = \frac{\rho}{t} \quad (2)
\]

Table 1: Electrical parameters of the nanostructured FTO thin films samples from 5 hours to 24 hours hydrothermal synthesis.

<table>
<thead>
<tr>
<th>No.</th>
<th>Sample</th>
<th>Resistance, ( R ) (Ω)</th>
<th>Resistivity, ( \rho \times 10^3 )</th>
<th>Sheet Resistance, ( R_s ) (Ω/cm²)</th>
<th>Average Thickness, ( t ) (nm)</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>5h</td>
<td>70.713</td>
<td>18.49</td>
<td>176.783</td>
<td>1046</td>
</tr>
<tr>
<td>2</td>
<td>10h</td>
<td>156.772</td>
<td>44.41</td>
<td>391.93</td>
<td>1133</td>
</tr>
<tr>
<td>3</td>
<td>24h</td>
<td>183.639</td>
<td>1.771</td>
<td>550.917</td>
<td>3857</td>
</tr>
</tbody>
</table>

C. Optical properties

The transmittance in the selected visible wavelength range corresponded to the time variation of hydrothermal synthesis was shown as in Fig. 6.

Figure 6: The transmittance of the nanostructured FTO thin film corresponding to the different time duration throughout the hydrothermal synthesis (a) 5h, (b) 10h, (c) 24h.

The oscillations in the visible region were due to the interference effects observed in FTO films. There were a considerable amount of decrement in the transparency of the samples as the time duration of hydrothermal synthesis increased from 5h to 24h which also led to the increment of the grain size of the nanostructured FTO thin film. In addition, the transmittance mainly depended on the film thickness, grain size, grain distribution and morphological structure. The sample fabricated for 5h had the highest transmittance of about 90-95% at wavelength 550nm, while for 10h, it was about 75-80% transmittance and for 24h was about 75-78% transmittance. For 24h, some milk spots were detected which might lead to the decrement of the transmittance. This variation was also attributed to the variation in free carrier concentration. From the transmittance that have been obtained, the direct band gap of the FTO samples were determined as depicted in Table 2 where all the values were around the theoretical value of 3.3-4.0eV [16-17]. The bandgap of the samples decreased as the time duration of the hydrothermal synthesis increased which might due to the Burstein-Moss Shift [18].

Table 2: The time duration of hydrothermal synthesis versus the bandgap, \( E_g \)

<table>
<thead>
<tr>
<th>No</th>
<th>Sample</th>
<th>Bandgap, ( E_g ) (eV)</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>5 hours</td>
<td>3.882</td>
</tr>
<tr>
<td>2</td>
<td>10 hours</td>
<td>3.765</td>
</tr>
<tr>
<td>3</td>
<td>24 hours</td>
<td>3.55</td>
</tr>
</tbody>
</table>
Conclusion

The FTO solution has been successfully synthesized by mixing 1.53M NH₄F and 0.8M SnCl₄.5H₂O together with propyl alcohol solution as the solvent. The fabrication of nanostructured FTO thin film was done by varying the time duration during hydrothermal process. The UV-Vis study revealed that the transmittance decreased from 90% to 75% when the time duration was increased from 5h to 24h. This was due to the better crystallized film and high transparency surface formed in shorter time duration. This result was supported by the FESEM characterization where the images shown that the seed layer formed on the FTO substrate increased with random grains distribution and the grain size growth increased as the time duration of hydrothermal process increased. The average grain sizes for 5h, 10h and 24h samples were 310nm, 465nm and 500nm, respectively. The figure of merit of nanostructured FTO has minimum resistance 176.783 Ω/cm² and over 80% for average transmittance. Another important finding of this research was different solution for hydrothermal synthesis could be made by preparing 0.1M DBTA where through FESEM characterization, nanocrystal growth was detected on the FTO crystal.

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References